Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/664,734	JONES ET AL.
Examiner	Art Unit

Adam L. Basehoar

2178

SEARCHED					
Class	Subclass	Date	Examiner		
715	530, 531	6/23/2007	ALB		
715	515, 516	6/23/2007	ALB		
715	523, 522	6/23/2007	ALB		
715	769, 770	6/23/2007	ALB		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Text Search	6/23/2007	ALB	
East Classification Search	6/23/2007	ALB	
eDAN: Inventor Name Search	6/23/2007	ALB	
NPL: INSPEC and IEEE Xplore Search	6/23/2007	ALB	
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